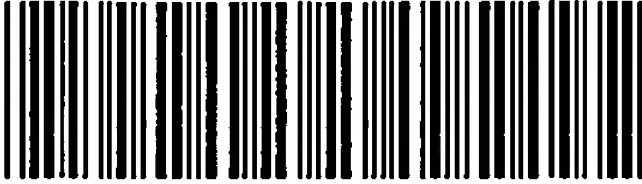


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/633,909	YEH ET AL.	
	Examiner	Art Unit	
	DAVID VU	2818	

SEARCHED			
Class	Subclass	Date	Examiner
438	623-624; 636-638	3/19/2005	DV

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	3/19/2005	DV